



## Product Change Notification / RMES-24GUAK186

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**Date:**

25-May-2023

**Product Category:**

Power MOSFET Drivers

**PCN Type:**

Manufacturing Change

**Notification Subject:**

CCB 6294 Final Notice: Qualification of MMT as an additional assembly site for selected MCP14A090xx, MCP14A120xx, MCP14A015xx, MCP14A060xx, MCP14A045xx and MCP14A03xx device families available in 8L TDFN (2x3x0.8mm) package.

**Affected CPNs:**

[RMES-24GUAK186\\_Affected\\_CPN\\_05252023.pdf](#)

[RMES-24GUAK186\\_Affected\\_CPN\\_05252023.csv](#)

**Notification Text:**

**PCN Status:**Final Notification

**PCN Type:**Manufacturing Change

**Microchip Parts Affected:**Please open one of the files found in the Affected CPNs section.

Note: For your convenience Microchip includes identical files in two formats (.pdf and .xls)

**Description of Change:**Qualification of MMT as an additional assembly site for selected MCP14A090xx, MCP14A120xx, MCP14A015xx, MCP14A060xx, MCP14A045xx and MCP14A03xx device families available in 8L TDFN (2x3x0.8mm) package.

**Pre and Post Change Summary:**

	Pre Change		Post Change		
Assembly Site	UTAC Thai Limited (UTL-1) LTD./ NSEB	UTAC Thai Limited (UTL-3)	UTAC Thai Limited (UTL-1) LTD./ NSEB	UTAC Thai Limited (UTL-3)	Microchip Technology Thailand (Branch) MMT
Wire Material	Au	Au	Au	Au	Au
Die Attach Material	8600	8600	8600	8600	3280
Molding Compound Material	G700LTD	G700LTD	G700LTD	G700LTD	G700LTD
Lead-Frame Material	C194	C194	C194	C194	A194*
Lead-lock Design (Locking Hole, Half Etched, Dimple, etc.)	Yes	Yes	Yes	Yes	No

Note: \* C194, A194 or CDA194 Lead frame material are the same, it is just a MCHP internal labelling difference.

**Impacts to Data Sheet:**None

**Change Impact:**None

**Reason for Change:**To improve on-time delivery performance by qualifying MMT as an additional assembly site.

**Change Implementation Status:**In Progress

**Estimated First Ship Date:**June 15, 2023 (date code: 2324)

Note: Please be advised that after the estimated first ship date customers may receive pre and post change parts.

**Time Table Summary:**

	May 2023				>	June 2023				
Workweek	1 8	1 9	2 0	2 1		2 2	2 3	2 4	2 5	2 6
Qual Report Availability				x						
Final PCN Issue Date				x						
Estimated Implementation Date								x		

**Method to Identify Change:**Traceability code

**Qualification Report:**Please open the attachments included with this PCN labeled as PCN\_#\_Qual\_Report.

**Revision History:**

**May 25, 2023:** Issued final notification. Attached is the Qualification Report. Provided estimated first ship date to be on June 15, 2023.

The change described in this PCN does not alter Microchip's current regulatory compliance regarding the material content of the applicable products.

**Attachments:**

[PCN\\_RMES-24GUAK186\\_Qual\\_Report.pdf](#)

[PCN\\_RMES-24GUAK186\\_Pre\\_and\\_Post Change Summary.pdf](#)

Please contact your local **Microchip sales office** with questions or concerns regarding this notification.

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If you wish to change your PCN profile, including opt out, please go to the **PCN home page** select login and sign into your myMicrochip account. Select a profile option from the left navigation bar and make the applicable selections.



## **QUALIFICATION REPORT SUMMARY**

### **RELIABILITY LABORATORY**

**PCN #: RMES-24GUAK186**

**Date:**  
**May 03, 2023**

**Qualification of MMT as an additional assembly site for selected  
MCP14A090xx, MCP14A120xx, MCP14A015xx, MCP14A060xx,  
MCP14A045xx and MCP14A03xx device families available in 8L TDFN  
(2x3x0.8mm) package will qualify by similarity (QBS).  
This is a Q100 Grade1 Qualification.**



## **MICROCHIP**

### **PACKAGE QUALIFICATION REPORT**

**Purpose** Qualification of MMT as an additional assembly site for selected MCP14A090xx, MCP14A120xx, MCP14A015xx, MCP14A060xx, MCP14A045xx and MCP14A03xx device families available in 8L TDFN (2x3x0.8mm) package will qualify by similarity (QBS). This is a Q100 Grade1 Qualification.

<b>CN</b>	E000074742
<b>QUAL ID</b>	R2101135 rev. A
<b>MP CODE</b>	VGKC2Y5QXA00
<b>Part No.</b>	MCP14A0154T-E/MNY
<b>Bonding No.</b>	BD-000235 Rev. 02
<b>CCB No.</b>	4672 and 6294
<b><u>Package</u></b>	
<b>Type</b>	8L TDFN
<b>Package size</b>	2 x 3 x 0.8 mm
<b><u>Lead Frame</u></b>	
<b>Paddle size</b>	83 x 71 mils
<b>Material</b>	A194
<b>Surface</b>	NiPdAu
<b>Process</b>	Etched
<b>Lead Lock</b>	No
<b>Part Number</b>	10100853
<b><u>Material</u></b>	
<b>Epoxy</b>	3280
<b>Wire</b>	Au wire
<b>Mold Compound</b>	G700LTD
<b>Plating Composition</b>	NiPdAu



## **MICROCHIP**

### **PACKAGE QUALIFICATION REPORT**

#### **Manufacturing Information:**

<b>Assembly Lot No.</b>	<b>Wafer No.</b>	<b>Date Code</b>
MMT-223202130.000	VS01921392675.500	2144M98
MMT-223202131.000	VS01921392675.500	2144M9A
MMT-223201699.000	VS01921392675.500	214426W

#### **Result**

☒ Pass ☐ Fail ☐ \_\_\_\_\_

8L TDFN (2x3x0.8 mm) assembled by MMT pass reliability test per QCI-39000. This package was qualified the Moisture/Reflow Sensitivity Classification Level 1 at 260°C reflow temperature per IPC/JEDEC J-STD-020E standard.

## PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS	Result	Remarks
<b>Precondition</b> <b>Prior Perform</b> <b>Reliability Tests</b> <b>(At MSL Level 1)</b>	<b>Electrical Test:</b> +25°C and 125°C System: ETS88	JESD22-A113	693(0)	693		Good Devices
	Bake 150°C, 24 hrs System: CHINEE	JIP/		693		
	85°C/85%RH Moisture Soak 168 hrs. System: TABAIESPEC Model PR-3SPH	IPC/JEDEC		693		
	3x Convection-Reflow 265°C max  System: Vitronics Soltec MR1243	J-STD-020E		693		
	<b>Electrical Test:</b> +25°C and 125°C System: ETS88			0/693	Pass	

# PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks
Temp Cycle	<b>Stress Condition:</b> -65°C to +150°C, 500 Cycles System: TABAIESPECTSA-70H <b>Electrical Test:</b> +125°C System: ETS88 <b>Bond Strength:</b> Wire Pull (> 2.50 grams) Bond Shear (>15.00 grams)	JESD22-A104	231(0)	231 0/231	Pass	Parts had been pre-conditioned at 260°C 77 units / lot
UNBIASED-HAST	<b>Stress Condition:</b> +130°C/85%RH, 96 hrs. System: HAST 6000X <b>Electrical Test:</b> +25°C System: ETS88	JESD22-A118	231(0)	231 0/231	Pass	Parts had been pre-conditioned at 260°C 77 units / lot
HAST	<b>Stress Condition:</b> +130°C/85%RH, 96 hrs. <b>Bias Volt:</b> 18 Volts System: HAST 6000X <b>Electrical Test:</b> +25°C and 125°C System: ETS88	JESD22-A110	231(0)	231 0/231	Pass	Parts had been pre-conditioned at 260°C 77 units / lot



# PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks
<b>High Temperature Storage Life</b>	<b>Stress Condition:</b> Bake 175°C, 500 hrs System: SHEL LAB  <b>Electrical Test:</b> +25°C and 125°C System: ETS88	JESD22-A103	45(0)	45  0/45	Pass	45 units
<b>Solderability Temp 215°C</b>	<b>Steam Aging:</b> Temp 93°C, 8Hrs System: SAS-3000 Solder Dipping: Solder Temp. 215°C Solder material: SnPb Sn63, Pb37 System: ERS A RA 2200D Visual Inspection: External Visual Inspection	J-STD-002	22 (0)	22  22  0/22	Pass	
<b>Solderability Temp 245°C</b>	<b>Steam Aging:</b> Temp 93°C, 8Hrs System: SAS-3000 Solder Dipping: Solder Temp. 245°C Solder material: Pb Free Sn 95.5Ag 3.9 Cu 0.6 System: ERS A RA 2200D Visual Inspection: External Visual Inspection	J-STD-002	22 (0)	22  22  0/22	Pass	
<b>Physical Dimensions</b>	Physical Dimension, 10 units / 1 lot	JESD22-B100/B108	30(0) Units	0/30	Pass	
<b>Bond Strength Data Assembly</b>	Wire Pull (>2.50 grams)	Mil. Std. 883-2011	30 (0) Wires	0/30	Pass	
	Bond Shear (>15.00 grams)	CDF-AEC-Q100-001	30 (0) bonds	0/30	Pass	

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Affected Catalog Part Numbers (CPN)

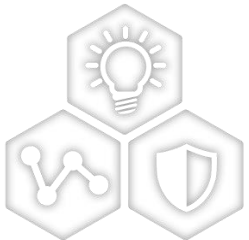
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MCP14A0153T-E/MNY  
MCP14A0154T-E/MNY  
MCP14A0155T-E/MNY  
MCP14A0601T-E/MNY  
MCP14A0602T-E/MNY  
MCP14A0453-E/MNY  
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MCP14A0304-E/MNY  
MCP14A0304T-E/MNY  
MCP14A0305-E/MNY  
MCP14A0305T-E/MNY

**CCB 6294**  
**Pre and Post Change Summary**  
**PCN #: RMES-24GUAK186**



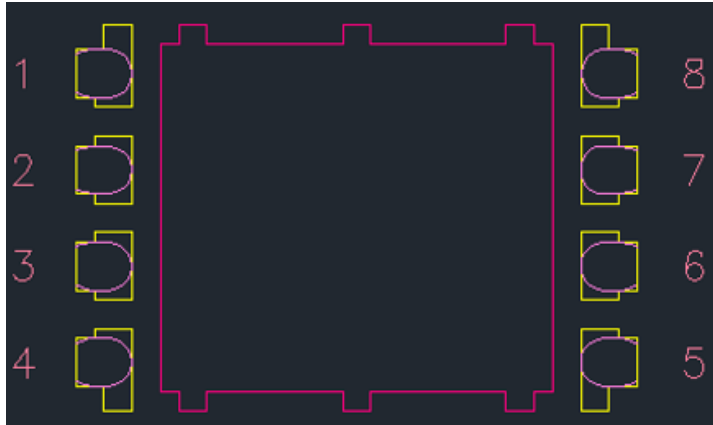
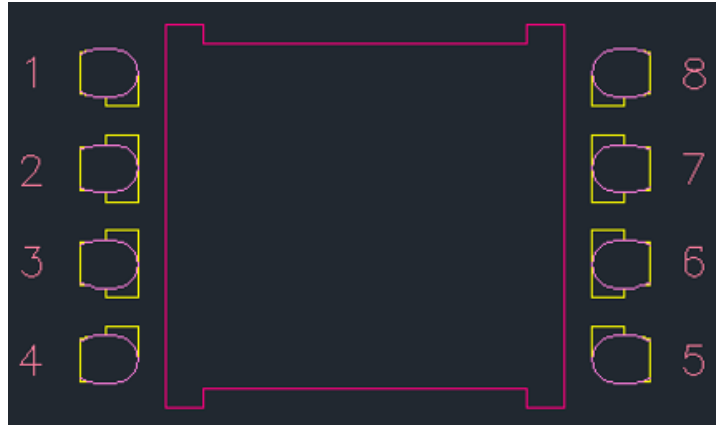
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# Pre and Post Change – Lead frame comparison

	NSEB (UTL-1) / UTL-3	MMT								
Lead Frame comparison	<div></div> <table><tr><td>Leadframe material</td><td>C194</td></tr><tr><td>Lead-lock Design (Locking Hole, Half Etched, Dimple, etc.)</td><td>Yes</td></tr></table>	Leadframe material	C194	Lead-lock Design (Locking Hole, Half Etched, Dimple, etc.)	Yes	<div></div> <table><tr><td>Leadframe material</td><td>A194*</td></tr><tr><td>Lead-lock Design (Locking Hole, Half Etched, Dimple, etc.)</td><td>No</td></tr></table>	Leadframe material	A194*	Lead-lock Design (Locking Hole, Half Etched, Dimple, etc.)	No
Leadframe material	C194									
Lead-lock Design (Locking Hole, Half Etched, Dimple, etc.)	Yes									
Leadframe material	A194*									
Lead-lock Design (Locking Hole, Half Etched, Dimple, etc.)	No									

Note: \* C194, A194 or CDA194 Lead frame material are the same, it is just a MCHP internal labelling difference.

Note: Not fit to scale for Lead frame drawing